

Notice of References Cited	Application/Control No. 10/652,024	Applicant(s)/Patent Under Reexamination DE MEYER ET AL.	
	Examiner Ronald D. Hartman Jr.	Art Unit 2121	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0180604	12-2002	Yamaashi et al.	340/573.1
*	B	US-2003/0061295	03-2003	Oberg et al.	709/208
*	C	US-6,167,464	12-2000	Kretschmann, Robert J.	710/15
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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